Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/765,872	TAKEZAWA ET AL.
Examiner	Art Unit

Phuong KT Dinh

2839

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Class	Subclass	Date	Examiner
439	267	5/12/2005	P.D
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TNI	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
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